## Notice of References Cited Application/Control No. 10/751,129 Examiner Kyung H. Shin Applicant(s)/Patent Under Reexamination NARSINH, ANEES Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,181,699 B1	01-2001	Crinion et al.	370/392
*	В	US-6,389,468 B1	05-2002	Muller et al.	709/226
	С	US-			
	D	US-			
	E	US-		·	
	F	US-			
	G	US-			
	H	US-			•
	1	US-		·	
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	,				
	0					
	P					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

	HON-I ATEN BOOMENTO				
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	v				
	w				
	х				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.